ON Semiconductor

Is Now



To learn more about onsemi™, please visit our website at www.onsemi.com

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/ or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application,



ON Semiconductor®

FDD3510H

Dual N & P-Channel PowerTrench® MOSFET

N-Channel: 80V, 13.9A, $80m\Omega$ P-Channel: -80V, -9.4A, $190m\Omega$

Features

Q1: N-Channel

■ Max $r_{DS(on)}$ = 80m Ω at V_{GS} = 10V, I_D = 4.3A

■ Max $r_{DS(on)}$ = 88m Ω at V_{GS} = 6V, I_D = 4.1A

Q2: P-Channel

■ Max $r_{DS(on)}$ = 190m Ω at V_{GS} = -10V, I_D = -2.8A

■ Max $r_{DS(on)}$ = 224m Ω at V_{GS} = -4.5V, I_D = -2.6A

■ 100% UIL Tested

■ RoHS Compliant



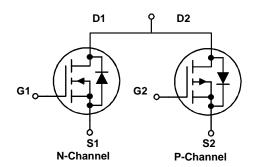
General Description

These dual N and P- Channel enhancement mode Power MOSFETs are produced using ON Semiconductor's advanced PowerTrench® process that has been especially tailored to minimize on -state resistance and yet maintain superior switching performance.

Applications

- Inverter
- H-Bridge





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DS}	Drain to Source Voltage		80	-80	V
V_{GS}	Gate to Source Voltage		±20	±20	V
	Drain Current - Continuous	T _C = 25°C	13.9	-9.4	
I _D	- Continuous	T _A = 25°C	4.3	-2.8	Α
	- Pulsed		20	-10	
	Power Dissipation for Single Operation	T _C = 25°C (Note 1)	35	32	
P_{D}		T _A = 25°C (Note 1a)	3.1		W
		$T_A = 25^{\circ}C$ (Note 1b)	1.3		
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	37	54	mJ
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	+150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case, Single Operation for Q1	(Note 1)	3.5	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Single Operation for Q2	(Note 1)	3.9	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD3510H	FDD3510H	TO-252-4L	13"	16mm	2500 units

Electrical Characteristics T_J = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Chara	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$ $I_D = -250 \mu A, V_{GS} = 0V$	Q1 Q2	80 -80			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250μA, referenced to 25°C I_D = -250μA, referenced to 25°C	Q1 Q2		84 -67	mV	/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64V, V _{GS} = 0V V _{DS} = -64V, V _{GS} = 0V	Q1 Q2			1 -1	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20V, V _{DS} = 0V	Q1 Q2			±100 ±100	nA nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = -250 \mu A$	Q1 Q2	2.0 -1.0	2.6 -1.6	4.0 -3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250μA, referenced to 25°C I_D = -250μA, referenced to 25°C	Q1 Q2		-6.7 4.6	mV/	°C
r	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 4.3A$ $V_{GS} = 6.0V, I_D = 4.1A$ $V_{GS} = 10V, I_D = 4.3A, T_J = 125^{\circ}C$	Q1		64 70 121	80 88 152	mΩ
r _{DS(on)}	Static Drain to Source On Resistance	V_{GS} = -10V, I_D = -2.8A V_{GS} = -4.5V, I_D = -2.6A V_{GS} = -10V, I_D = -2.8A, T_J = 125°C	Q2		153 184 259	190 224 322	11122
9 _{FS}	Forward Transconductance	$V_{DD} = 10V, I_D = 4.3A$ $V_{DD} = -5V, I_D = -2.8A$	Q1 Q2		15 6.8		S

Dynamic Characteristics

C _{iss}	Input Capacitance	Q1 V _{DS} = 40V, V _{GS} = 0V, f = 1MHZ	Q1 Q2	600 660	800 880	pF
C _{oss}	Output Capacitance	Q2	Q1 Q2	56 50	75 70	pF
C _{rss}	Reverse Transfer Capacitance	$V_{DS} = -40V, V_{GS} = 0V, f = 1MHZ$	Q1 Q2	27 25	41 40	pF
R _g	Gate Resistance	f = 1MHz	Q1 Q2	1.7 7.2		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	Q1	Q1 Q2	7 6	13 11	ns
t _r	Rise Time	$V_{DD} = 40V, I_D = 4.3A,$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	Q1 Q2	2 3	10 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2 V _{DD} = -40V, I _D = -2.8A,	Q1 Q2	16 25	29 40	ns
t _f	Fall Time	$V_{GS} = -10V$, $R_{GEN} = 6\Omega$	Q1 Q2	2 5	10 10	ns
Q _{g(TOT)}	Total Gate Charge	Q1	Q1 Q2	13 14	18 20	nC
Q _{gs}	Gate to Source Charge	$V_{GS} = 10V, V_{DD} = 40V, I_D = 4.3A$ $Q2$	Q1 Q2	2.3 1.9		nC
Q _{gd}	Gate to Drain "Miller" Charge	$V_{GS} = -10V, V_{DD} = -40V, I_D = -2.8A$	Q1 Q2	3.2 2.9		nC

Units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Parameter

Drain-S	ource Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.6A$ (N $V_{GS} = 0V, I_S = -2.6A$ (N	Note 2) Note 2)	Q1 Q2	8.0 -0.8	1.2 -1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 4.3A, di/dt = 100A/s		Q1 Q2	29 30	46 48	ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = -2.8A, di/dt = 100A/s		Q1 Q2	28 30	45 48	nC

Test Conditions

Type

Min

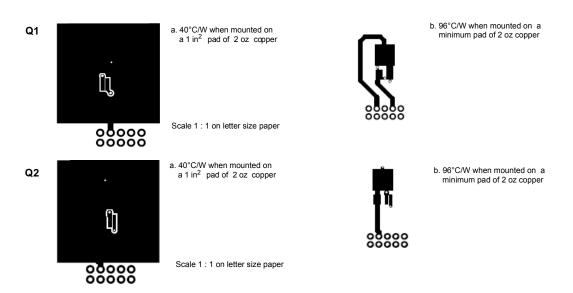
Тур

Max

Notes

Symbol

1. $R_{\theta JA}$ is determined with the device mounted on a 1in^2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.
- 3. Starting T_J = 25°C, N-ch: L = 3mH, I_{AS} = 5A, V_{DD} = 80V, V_{GS} = 10V; P-ch: L = 3mH, I_{AS} = -6A, V_{DD} = -80V, V_{GS} = -10V.

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

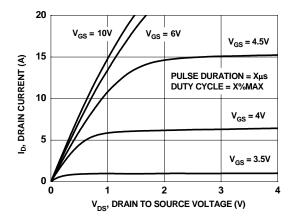


Figure 1. On Region Characteristics

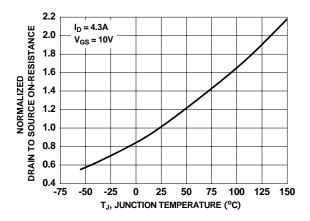


Figure 3. Normalized On Resistance vs Junction Temperature

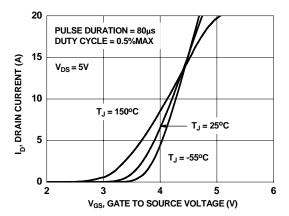


Figure 5. Transfer Characteristics

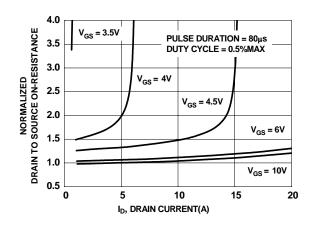


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

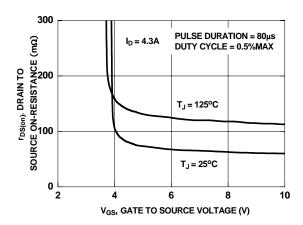


Figure 4. On-Resistance vs Gate to Source Voltage

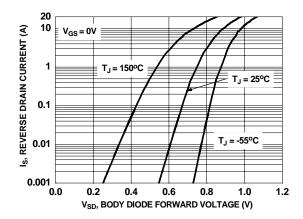


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

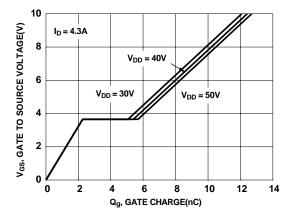


Figure 7. Gate Charge Characteristics

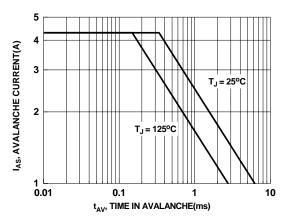


Figure 9. Unclamped Inductive Switching Capability

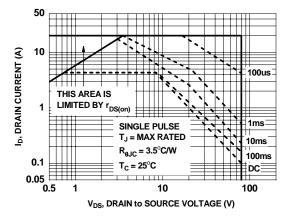


Figure 11. Forward Bias Safe Operating Area

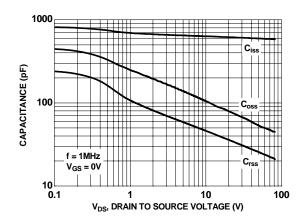


Figure 8. Capacitance vs Drain to Source Voltage

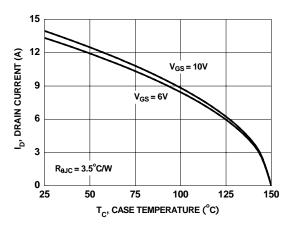


Figure 10. Maximum Continuous Drain Current vs Case Temperature

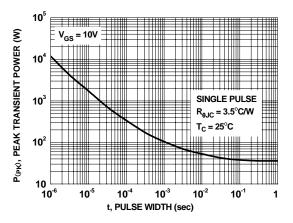


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) T_J = 25°C unless otherwise noted

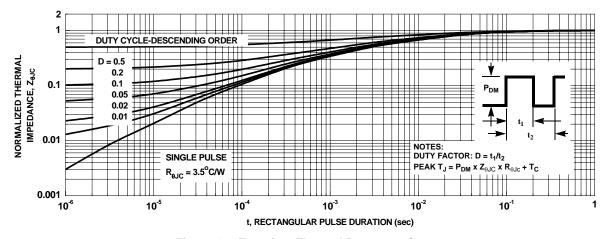


Figure 13. Transient Thermal Response Curve

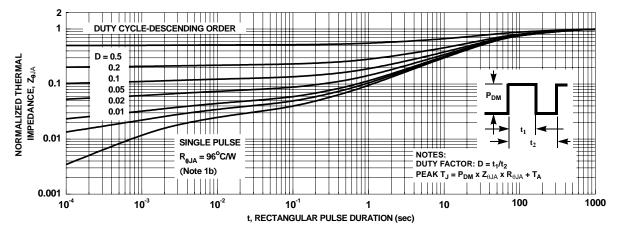


Figure 14. Transient Thermal Response Curve

Typical Characteristics (Q2 P-Channel) T_J = 25°C unless otherwise noted

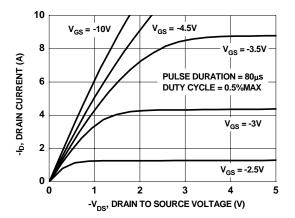


Figure 15. On- Region Characteristics

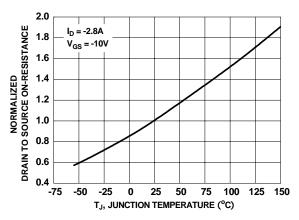


Figure 17. Normalized On-Resistance vs Junction Temperature

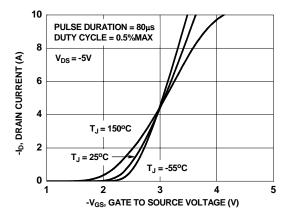


Figure 19. Transfer Characteristics

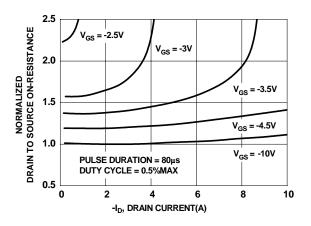


Figure 16. Normalized on-Resistance vs Drain Current and Gate Voltage

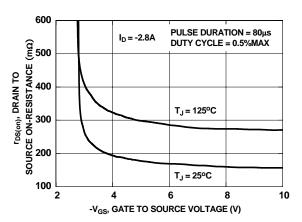


Figure 18. On-Resistance vs Gate to Source Voltage

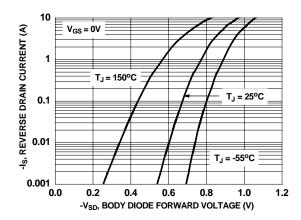


Figure 20. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q2 P-Channel)T_J = 25°C unless otherwise noted

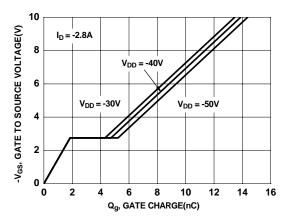


Figure 21. Gate Charge Characteristics

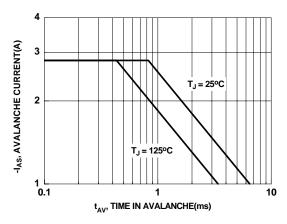


Figure 23. Unclamped Inductive Switching Capability

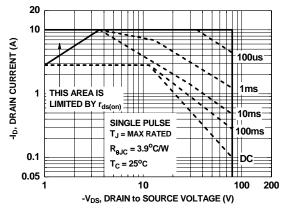


Figure 25. Forward Bias Safe Operating Area

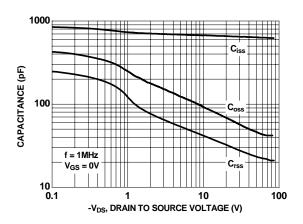


Figure 22. Capacitance vs Drain to Source Voltage

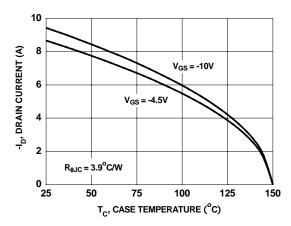


Figure 24. Maximum Continuous Drain Current vs Case Temperature

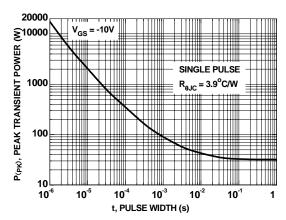


Figure 26. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 P-Channel)T_J = 25°C unless otherwise noted

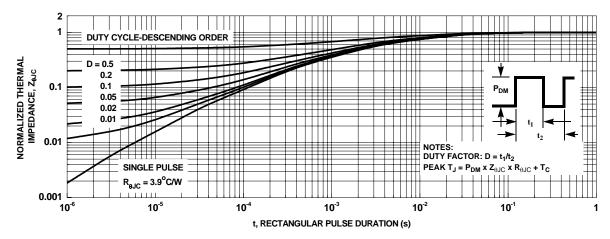


Figure 27. Transient Thermal Response Curve

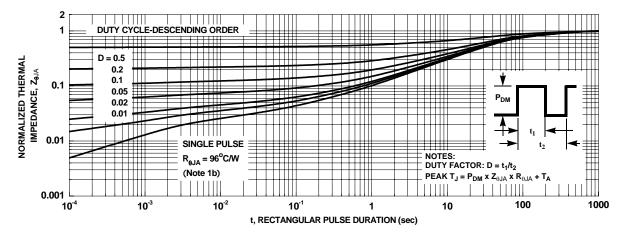


Figure 28. Transient Thermal Response Curve

ON Semiconductor and III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages.

Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative